

**Amendments to the Specification**

Please replace the "Related Applications" paragraph after the Title at page 1, lines 6-11, with a clean version of the following marked up paragraph:

This application is the U.S. National Stage of International Application No. PCT/US2004/017251, filed June 1, 2004, published in English, and claims priority under 35 U.S.C. § 365 to a continuation-in-part of U.S. Application No. 10/683,903, filed October 10, 2003, which claims the benefit of U.S. Provisional Application No. 60/475,145, filed on June 2, 2003; and ~~This application is also a continuation-in-part of U.S. Application No. 10/683,904, filed October 10, 2003, which claims the benefit of U.S. Provisional Application No. 60/475,145, filed on June 2, 2003.~~ The entire teachings of the above applications are incorporated herein by reference.

Please replace the paragraph at page 20, lines 1-10, with a clean version of the following marked-up paragraph:

FIG. 23 is a graph 1600 of time 1602 versus ethylbenzene concentration 1604 for four purge gas mixtures exiting the wafer chamber of FIG. 5, the purge gases containing 100% nitrogen, 20% oxygen, 0.5% water and 100 ppm water according to an embodiment of the present invention. The hydrocarbon-nitrogen contamination mixture was 60 ppb total hydrocarbon concentration, as described in Example 1. Data representing the purge response of ethylbenzene to UHP nitrogen ~~1606~~ 1608, 20% oxygen (by volume) in nitrogen ~~1608~~ 1606, 100 ppm water (by volume) in nitrogen 1610 and 0.5% water (by volume) in nitrogen 1612 are plotted in graph 1600. Purging effectiveness increases as water concentration increases within the ranges of water concentration shown.